

**Notice of References Cited**

Application/Control No.

10/055,545

Applicant(s)/Patent Under  
Reexamination  
WU ET AL.

Examiner

David Y. Chung

Art Unit

2871

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,485,997	11-2002	Lee et al.	438/30
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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